

## ECELCAH5V5U

Ultra Low Capacitance Array for ESD Protection

The ECELCAH5V5U provides a typical line to line capacitance of 0.15pF between I/O pins and low insertion loss up to 3GHz providing greater signal integrity making it ideally suited for HDMI applications, such as Digital TVs, DVD players, Computing, set-top boxes and MDDI applications in mobile computing devices.

It has been specifically designed to protect sensitive components which are connected to high-speed data and transmission lines from overvoltage caused by ESD(electrostatic discharge), CDE (Cable Discharge Events), and EFT (electrical fast transients).

#### Features

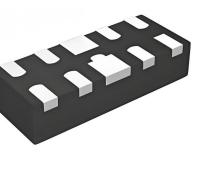
- Protects two or four I/O lines
- Low capacitance:0.15pf Typical between I/O channel
- Working voltages : 5.5V
- Low leakage current
- Response Time is < 1 ns
- Meets MSL 1 Requirements
- Solid-state silicon avalanche technology
- ROHS compliant

### **Main applications**

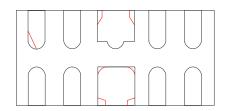
- High Definition Multi-Media Interface (HDMI1.3/1.4/2.0)
- Digital Visual Interface (DVI)
- Display Port Interface
- Serial ATA
- PCI Express
- USB 1.1/2.0/3.0/3.1/OTG
- IEEE 1394 Firewire Ports
- Projection TV Monitors and Flat Panel Displays
- Notebook Computers
- Set Top Box
- Projection TV

## **Protection solution to meet**

- IEC61000-4-2 (ESD) ±20kV (air), ±20kV (contact)
- IEC61000-4-4 (EFT) 40A (5/50ns)
- IEC61000-4-5 (Lightning) 3.5A (8/20µs)



**DFN2510** 



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10	9	8	7 6	

#### **Ordering Information**

Device	Marking	Qty per Reel	Reel Size
ECELCAH5V5U	0524P	3000	7 Inch

www.ecore-union.com

# **É**core

## ECELCAH5V5U

#### Maximum ratings (Temp=25°C Unless Otherwise Specified) Parameter Symbol Value Unit Peak Pulse Power (tp=8/20µs waveform) Рррр 45 Watts 3.5 Peak Pulse Current(tp=8/20µs waveform) IPP А ESD Rating per IEC61000-4-2: 20 Contact KV Air 20 Lead Soldering Temperature $T_{\rm L}$ 260 (10 sec.) °C Тյ -55 ~ 150 °C **Operating Temperature Range** °C Storage Temperature Range Tstg $-55 \sim 150$

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

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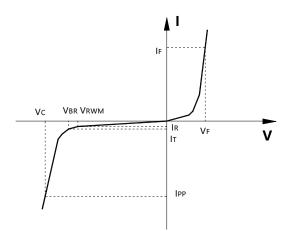
\*Other voltages may be available upon request.

1. Non-repetitive current pulse, per Figure 1.

Electric	al characteristics ( Temp=2	5℃ Unless Otherwise Specif	fied)			
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
Vrwm	Reverse Working Voltage	Any I/O to Ground			5.5	V
V	D	IT = 1 mA,	6.0			v
Vbr	Reverse Breakdown Voltage	Any I/O to Ground	0.0			v
Ir	Doverso Lookago Current	$V_{RWM} = 5V,$			0.5	
IR	Reverse Leakage Current	Any I/O to Ground			0.5	μΑ
VF	Diode Forward Voltage	IF = 15mA		0.85	1.2	V
		$I_{PP} = 1A$ , tp =8/20µs,		8.6	9.8	v v
N7		any I/O pin to Ground				
Vc	Clamping Voltage	$I_{PP} = 3A$ , tp =8/20µs,		11.4	15	
		any I/O pin to Ground			15	
Rdyn	dynamic resistance	positive transient		0.48		Ω
Kuyii	dynamic resistance	negative transient		0.35		52
C	Investige Constitution	$V_R = 0V, f = 1MHz,$		0.1	0.25	pF
		between I/O pins				
CJ	Junction Capacitance	$V_{R} = 0V, f = 1MHz,$		0.36	0.6	рF
		any I/O pin to Ground		0.50	0.0	pF

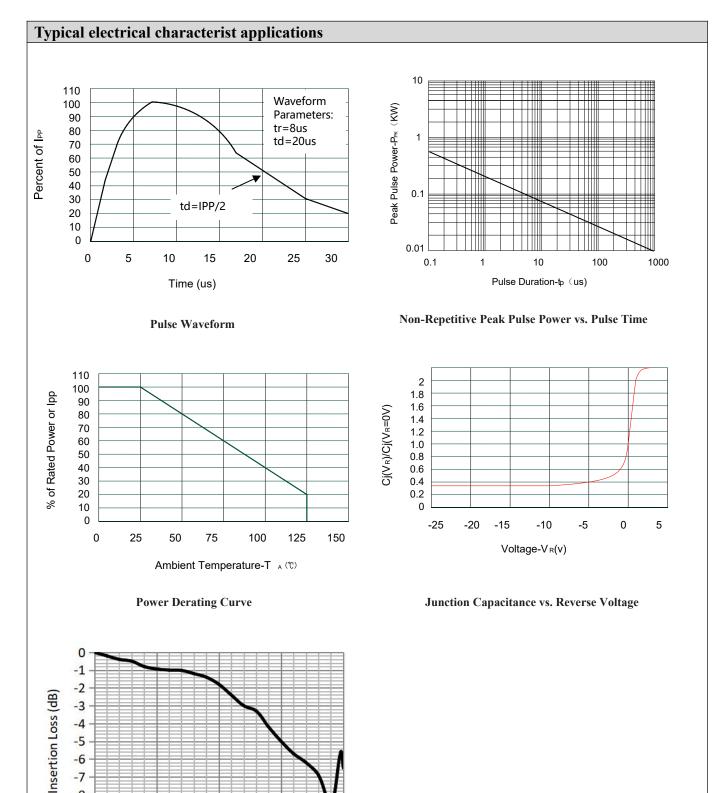
Junction capacitance is measured in VR=0V,F=1MHz

Symbol	Parameter
Vrwm	Working Peak Reverse Voltage
VBR	Breakdown Voltage @ IT
$V_{\rm C}$	Clamping Voltage @ IPP
I <sub>T</sub>	Test Current
Irm	Leakage current at VRWM
Ipp	Peak pulse current
Co	Off-state Capacitance
CJ	Junction Capacitance





## ECELCAH5V5U



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Frequency (GHz)

**Insertion Loss S21** 

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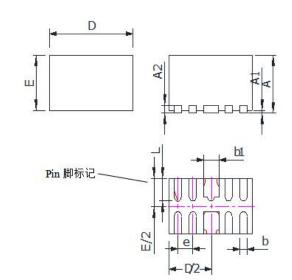
-7 --8 --9 --10 -

20



## **Package Information**

DFN2510



DIN	Millimeters		
DIM	Min	Max	
A	0.45	0.65	
A1	0.05REF		
A2	0.15REF		
b	0.15	0.15 0.25	
b1	0.30	0.50	
D	2.424	2.576	
E	0.924	1.076	
e	0.50REF		
L	0.30	0.45	

## **Recommended Pad outline**

